

**Phase-out/Discontinued**

### SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

#### DESCRIPTION

This product is Dual N-channel MOS Field Effect Transistor designed for DC/DC converters and power management applications of notebook computers.

#### FEATURES

- Dual chip type
- Low on-resistance  
 $R_{DS(on)1} = 32 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 3.5 \text{ A)}$   
 $R_{DS(on)2} = 45 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 3.5 \text{ A)}$
- Low input capacitance  $C_{iss} = 895 \text{ pF TYP.}$
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

#### ORDERING INFORMATION

| PART NUMBER | PACKAGE    |
|-------------|------------|
| μPA1755G    | Power SOP8 |

#### ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25 °C, All terminals are connected.)

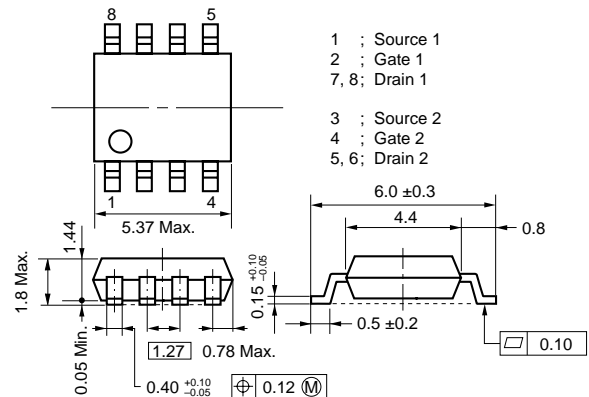
|   |                       |              |    |
|---|-----------------------|--------------|----|
| Drain to Source Voltage (V <sub>GS</sub> = 0)     | V <sub>DSS</sub>      | 30           | V  |
| Gate to Source Voltage (V <sub>DS</sub> = 0)      | V <sub>GSS</sub>      | ±20          | V  |
| Drain Current (DC)                                | I <sub>D(DC)</sub>    | ±7.0         | A  |
| Drain Current (pulse) <sup>Note1</sup>            | I <sub>D(pulse)</sub> | ±28          | A  |
| Total Power Dissipation (1 unit) <sup>Note2</sup> | P <sub>T</sub>        | 1.7          | W  |
| Total Power Dissipation (2 unit) <sup>Note2</sup> | P <sub>T</sub>        | 2.0          | W  |
| Channel Temperature                               | T <sub>ch</sub>       | 150          | °C |
| Storage Temperature                               | T <sub>stg</sub>      | -55 to + 150 | °C |

**Notes 1.** PW ≤ 10 μs, Duty cycle ≤ 1 %

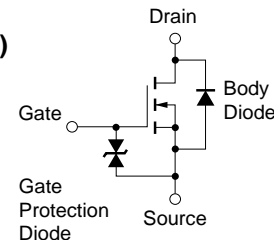
**2.** T<sub>A</sub> = 25 °C, Mounted on ceramic substrate of 2000 mm<sup>2</sup> x 1.1 mm

**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

#### PACKAGE DRAWING (Unit : mm)



#### EQUIVALENT CIRCUIT (1/2 Circuit)

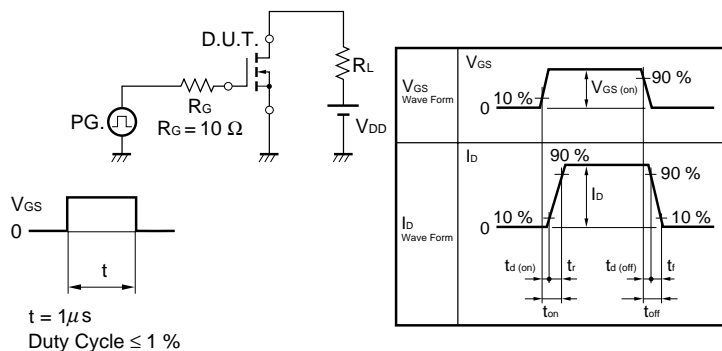


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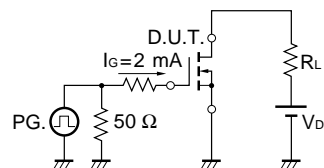
**ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)**

| CHARACTERISTICS                     | SYMBOL               | TEST CONDITIONS                                 | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Drain to Source On-state Resistance | R <sub>DS(on)1</sub> | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.5 A  |      | 22   | 32   | mΩ   |
|                                     | R <sub>DS(on)2</sub> | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 3.5 A |      | 32   | 45   | mΩ   |
| Gate to Source Cut-off Voltage      | V <sub>GS(off)</sub> | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA   | 1.5  | 2.0  | 2.5  | V    |
| Forward Transfer Admittance         | y <sub>fs</sub>      | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.5 A  | 4.0  | 8.0  |      | S    |
| Drain Leakage Current               | I <sub>DSS</sub>     | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0     |      |      | 10   | μA   |
| Gate to Source Leakage Current      | I <sub>GSS</sub>     | V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0    |      |      | ±10  | μA   |
| Input Capacitance                   | C <sub>iss</sub>     | V <sub>DS</sub> = 10 V                          |      | 895  |      | pF   |
| Output Capacitance                  | C <sub>oss</sub>     | V <sub>GS</sub> = 0                             |      | 335  |      | pF   |
| Reverse Transfer Capacitance        | C <sub>rss</sub>     | f = 1 MHz                                       |      | 150  |      | pF   |
| Turn-on Delay Time                  | t <sub>d(on)</sub>   | I <sub>D</sub> = 3.5 A                          |      | 16   |      | ns   |
| Rise Time                           | t <sub>r</sub>       | V <sub>GS(on)</sub> = 10 V                      |      | 130  |      | ns   |
| Turn-off Delay Time                 | t <sub>d(off)</sub>  | V <sub>DD</sub> = 15 V                          |      | 55   |      | ns   |
| Fall Time                           | t <sub>f</sub>       | R <sub>G</sub> = 10 Ω                           |      | 30   |      | ns   |
| Total Gate Charge                   | Q <sub>G</sub>       | I <sub>D</sub> = 7.0 A                          |      | 19   |      | nC   |
| Gate to Source Charge               | Q <sub>GS</sub>      | V <sub>DD</sub> = 24 V                          |      | 2.2  |      | nC   |
| Gate to Drain Charge                | Q <sub>GD</sub>      | V <sub>GS</sub> = 10 V                          |      | 5.4  |      | nC   |
| Body Diode forward Voltage          | V <sub>F(S-D)</sub>  | I <sub>F</sub> = 7.0 A, V <sub>GS</sub> = 0     |      | 0.8  |      | V    |
| Reverse Recovery Time               | t <sub>rr</sub>      | I <sub>F</sub> = 7.0 A, V <sub>GS</sub> = 0     |      | 45   |      | ns   |
| Reverse Recovery Charge             | Q <sub>rr</sub>      | di/dt = 100 A/μs                                |      | 62   |      | nC   |

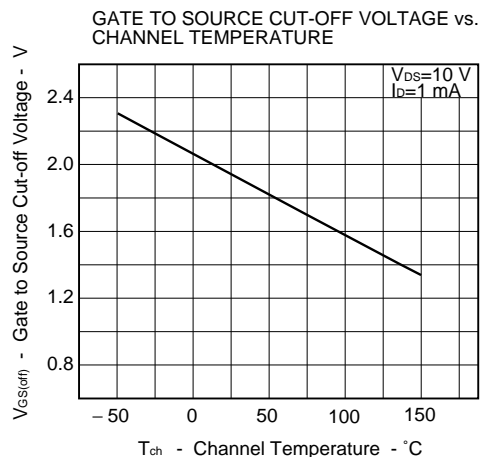
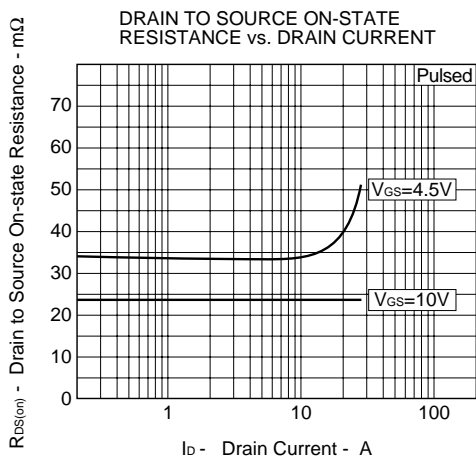
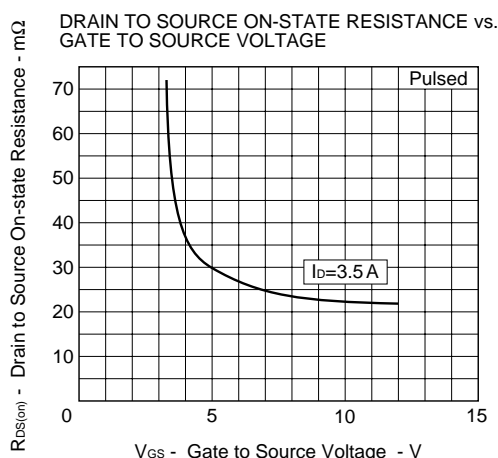
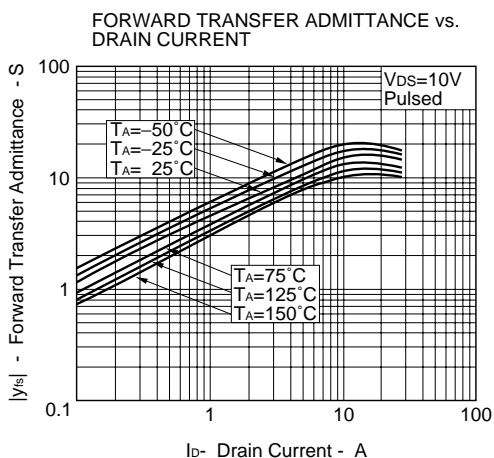
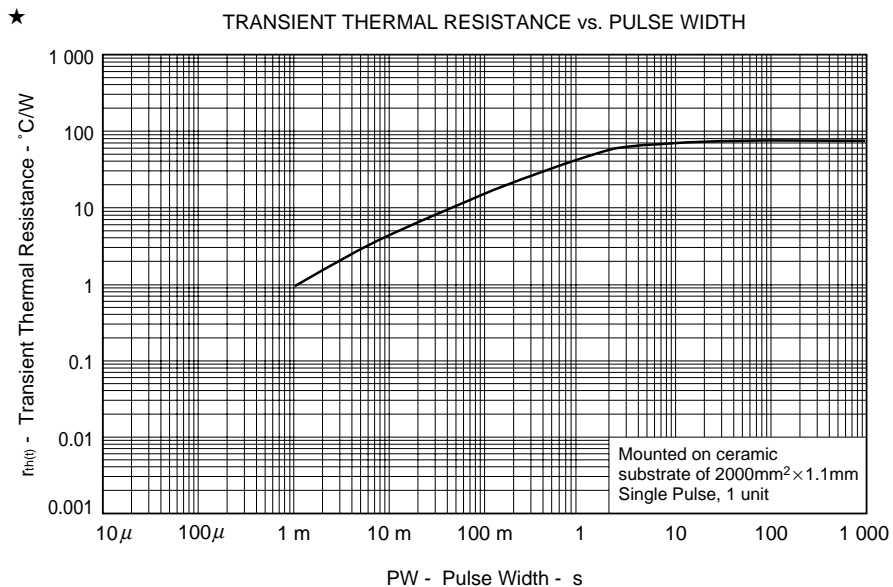
**TEST CIRCUIT 1 SWITCHING TIME**

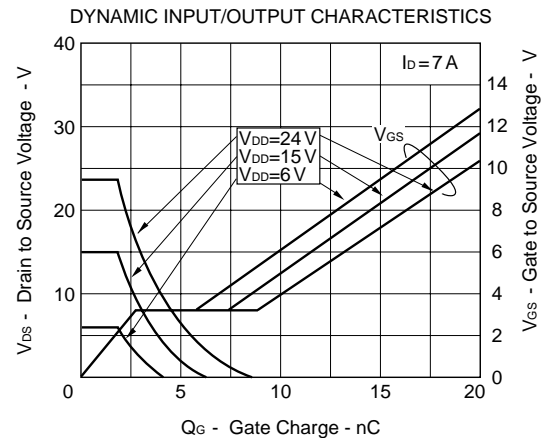
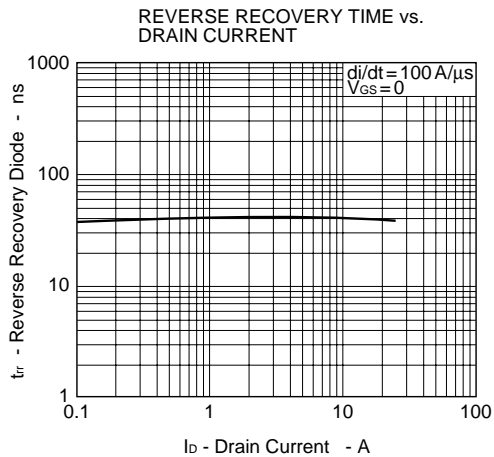
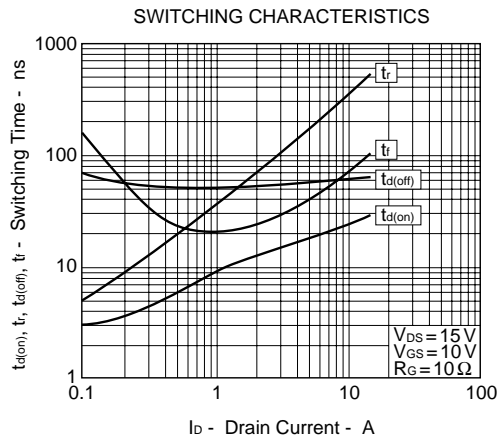
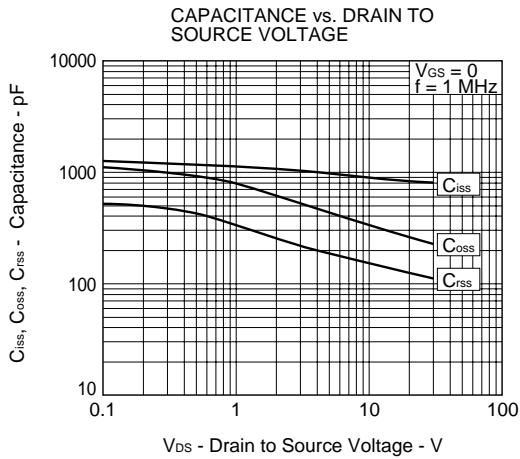
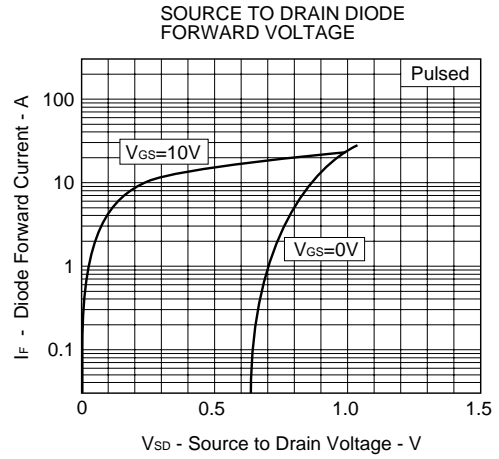
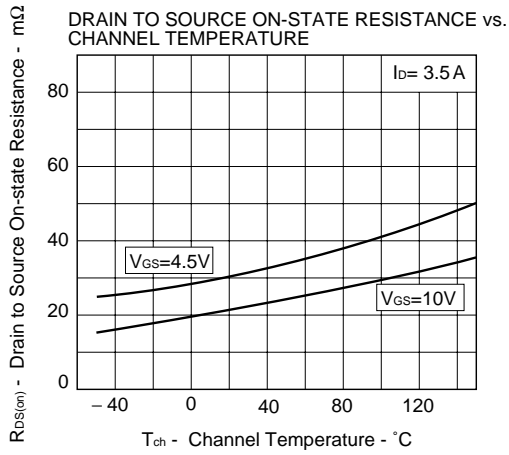


**TEST CIRCUIT 2 GATE CHARGE**

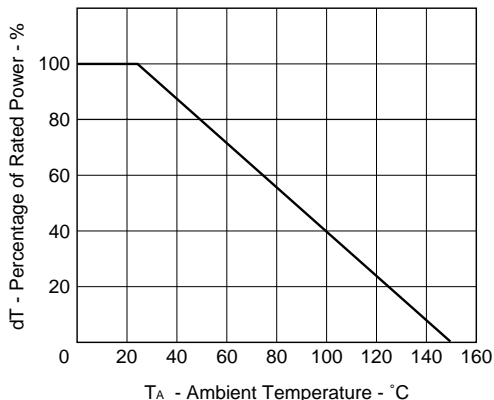


TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ )

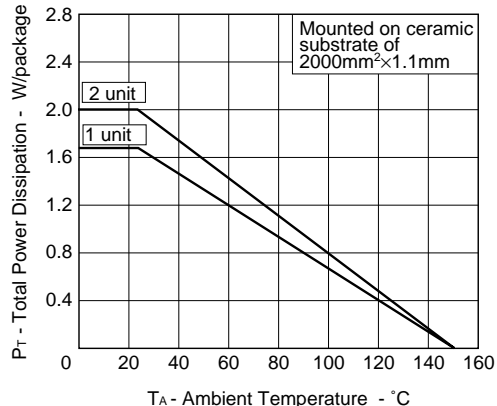




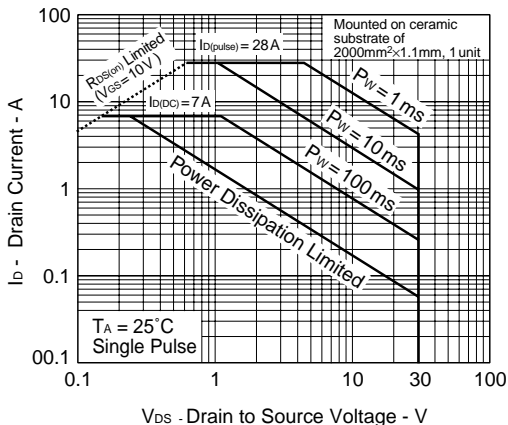
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



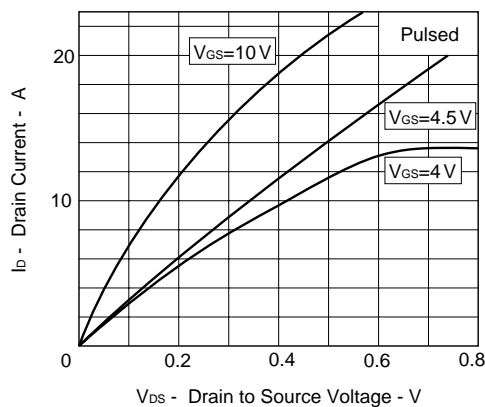
TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



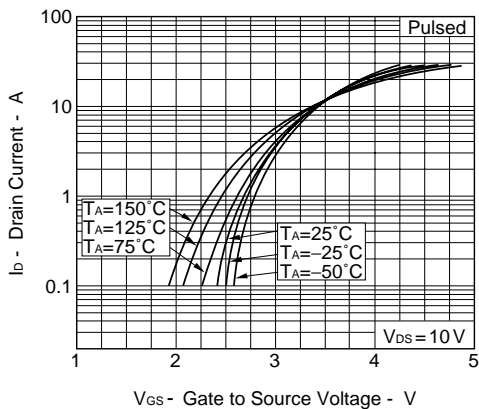
★ FORWARD BIAS SAFE OPERATING AREA



DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



FORWARD TRANSFER CHARACTERISTICS



[MEMO]

[MEMO]

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